

SEMiX453GAR12E4s



SEMiX® 3s

Trench IGBT Modules

SEMiX453GAR12E4s

Features

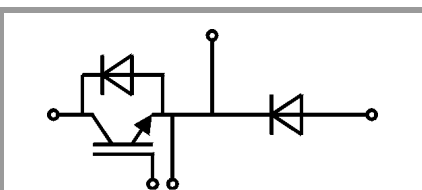
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C = 125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j = 150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 1,0 \Omega$
 $R_{Goff,main} = 1,0 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$



GAR

Absolute Maximum Ratings

Symbol	Conditions	Values	Unit	
IGBT				
V_{CES}	$T_j = 25^\circ\text{C}$	1200	V	
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	683	A
		$T_c = 80^\circ\text{C}$	526	A
I_{Cnom}		450	A	
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$	1350	A	
V_{GES}		-20 ... 20	V	
t_{psc}	$V_{CC} = 800\text{ V}$	$T_j = 150^\circ\text{C}$	10	μs
	$V_{GE} \leq 20\text{ V}$			
	$V_{CES} \leq 1200\text{ V}$			
T_j		-40 ... 175	$^\circ\text{C}$	
Inverse diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	544	A
		$T_c = 80^\circ\text{C}$	407	A
I_{Fnom}		450	A	
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$	1350	A	
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$	2430	A	
T_j		-40 ... 175	$^\circ\text{C}$	
Freewheeling diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	544	A
		$T_c = 80^\circ\text{C}$	407	A
I_{Fnom}		450	A	
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$	1350	A	
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$	2430	A	
T_j		-40 ... 175	$^\circ\text{C}$	
Module				
$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$	600	A	
T_{stg}		-40 ... 125	$^\circ\text{C}$	
V_{isol}	AC sinus 50Hz, $t = 1\text{ min}$	4000	V	

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 450\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.8	2.05	V
		$T_j = 150^\circ\text{C}$	2.2	2.4	V
V_{CE0}		$T_j = 25^\circ\text{C}$	0.8	0.9	V
		$T_j = 150^\circ\text{C}$	0.7	0.8	V
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	2.2	2.6	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	3.3	3.6	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 18\text{ mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25^\circ\text{C}$	0.1	0.3	mA
		$T_j = 150^\circ\text{C}$			mA
C_{ies}	$V_{CE} = 25\text{ V}$		27.9		nF
C_{oes}	$V_{GE} = 0\text{ V}$		1.74		nF
C_{res}			1.53		nF
Q_G	$V_{GE} = -8\text{ V...} + 15\text{ V}$		2550		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		1.67		Ω

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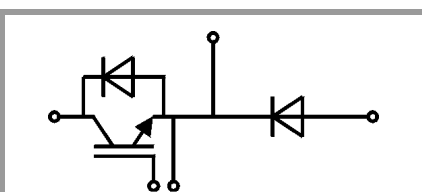
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Remarks

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- Dynamic values apply to the following combination of resistors:
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 $R_{E,X} = 0,5 \Omega$



GAR

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$		336		ns
t_r	$I_C = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		80		ns
E_{on}	$V_{GE} = \pm 15 \text{ V}$	$T_j = 150^\circ\text{C}$		45		mJ
$t_{d(off)}$	$R_{G on} = 1.9 \Omega$	$T_j = 150^\circ\text{C}$		615		ns
t_f	$R_{G off} = 1.9 \Omega$	$T_j = 150^\circ\text{C}$		130		ns
E_{off}	$di/dt_{on} = 4000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		66.5		mJ
	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per IGBT				0.065	K/W
Inverse diode						
$V_F = V_{EC}$	$I_F = 450 \text{ A}$	$T_j = 25^\circ\text{C}$		2.1	2.46	V
	$V_{GE} = 0 \text{ V}$	$T_j = 150^\circ\text{C}$		2.1	2.4	V
	chip					
V_{F0}		$T_j = 25^\circ\text{C}$	1.1	1.3	1.5	V
		$T_j = 150^\circ\text{C}$	0.7	0.9	1.1	V
r_F		$T_j = 25^\circ\text{C}$	1.4	1.9	2.1	m Ω
		$T_j = 150^\circ\text{C}$	2.2	2.6	2.8	m Ω
I_{RRM}	$I_F = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		350		A
Q_{rr}	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		70		μC
E_{rr}	$V_{GE} = -15 \text{ V}$	$T_j = 150^\circ\text{C}$		28		mJ
	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per diode				0.11	K/W
Freewheeling diode						
$V_F = V_{EC}$	$I_F = 450 \text{ A}$	$T_j = 25^\circ\text{C}$		2.1	2.46	V
	$V_{GE} = 0 \text{ V}$	$T_j = 150^\circ\text{C}$		2.1	2.4	V
	chip					
V_{F0}		$T_j = 25^\circ\text{C}$	1.1	1.3	1.5	V
		$T_j = 150^\circ\text{C}$	0.7	0.9	1.1	V
r_F		$T_j = 25^\circ\text{C}$	1.4	1.9	2.1	m Ω
		$T_j = 150^\circ\text{C}$	2.2	2.6	2.8	m Ω
I_{RRM}	$I_F = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		350		A
Q_{rr}	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		70		μC
E_{rr}	$V_{GE} = -15 \text{ V}$	$T_j = 150^\circ\text{C}$		28		mJ
	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per diode				0.11	K/W
Module						
L_{CE}				20		nH
R_{CC+EE}	res., terminal-chip	$T_C = 25^\circ\text{C}$		0.7		m Ω
		$T_C = 125^\circ\text{C}$		1		m Ω
$R_{th(c-s)}$	per module			0.04		K/W
M_s	to heat sink (M5)		3		5	Nm
M_t		to terminals (M6)	2.5		5	Nm
						Nm
w					300	g
Temperatur Sensor						
R_{100}	$T_C=100^\circ\text{C}$ ($R_{25}=5 \text{ k}\Omega$)			$493 \pm 5\%$		Ω
$B_{100/125}$	$R(T)=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; $T[\text{K}]$;			$3550 \pm 2\%$		K

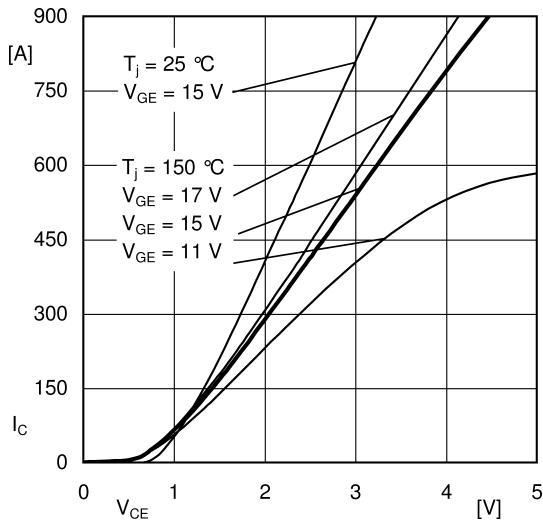


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+EE'}$

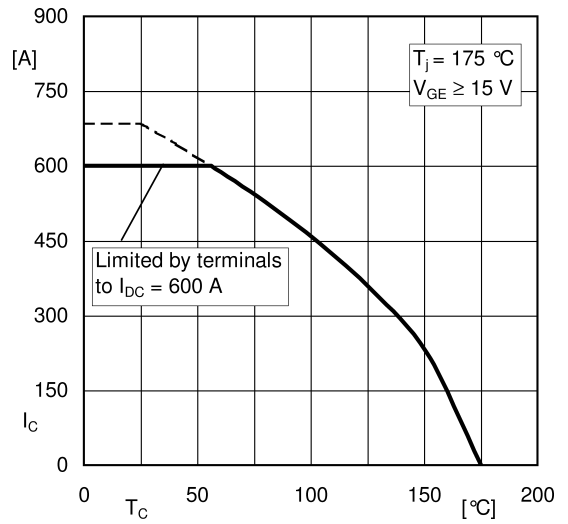


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

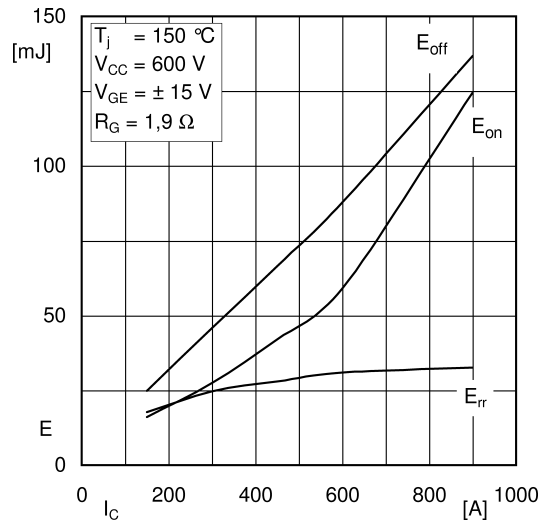


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

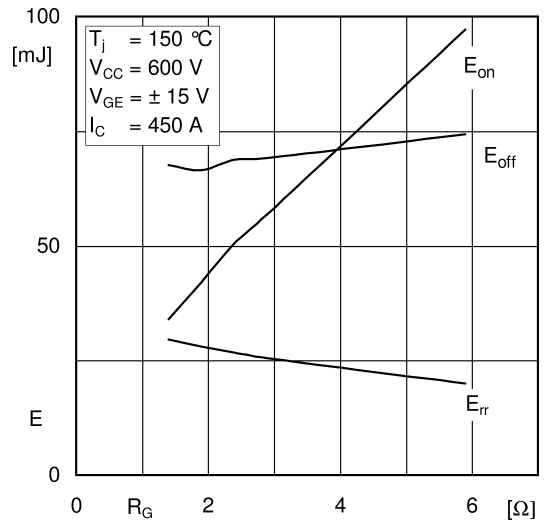


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

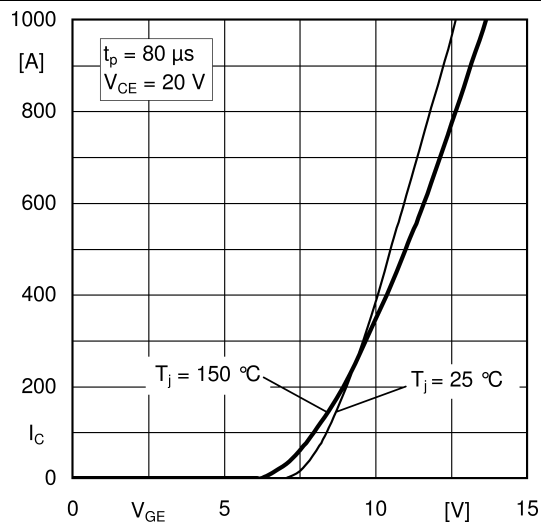


Fig. 5: Typ. transfer characteristic

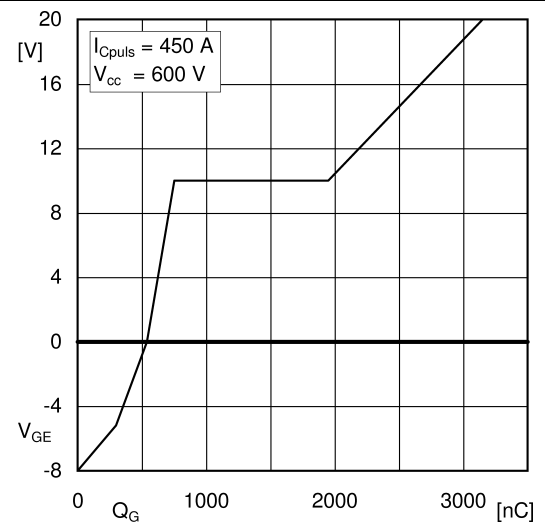
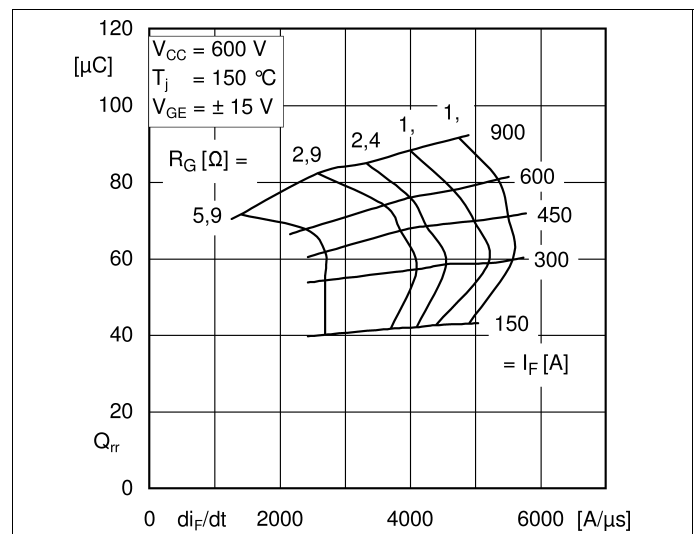
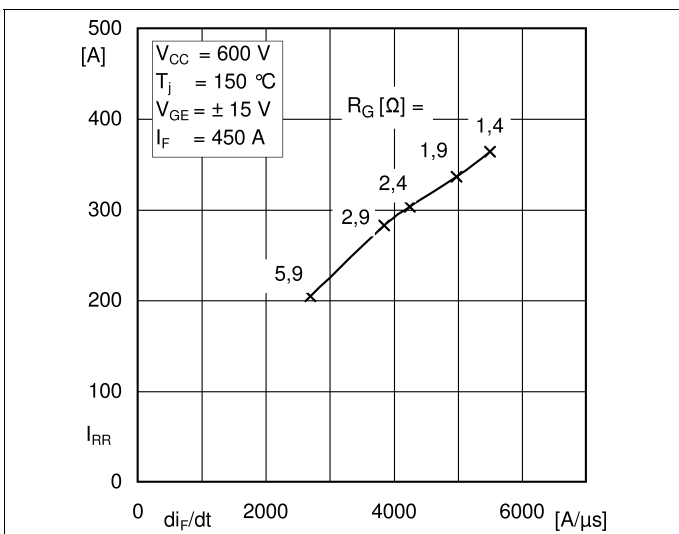
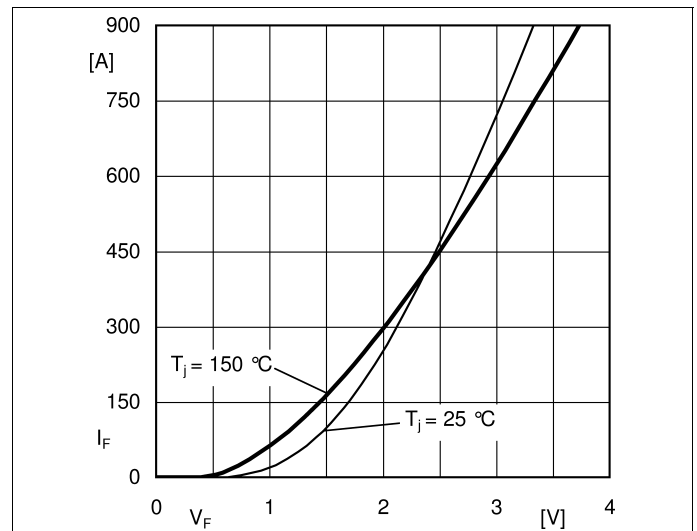
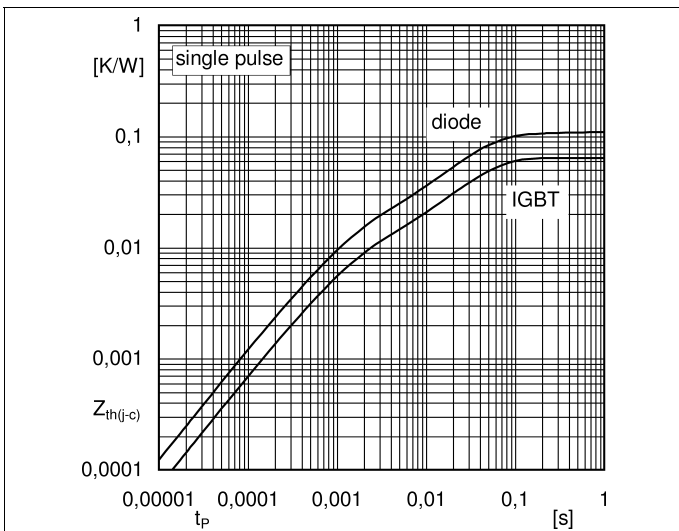
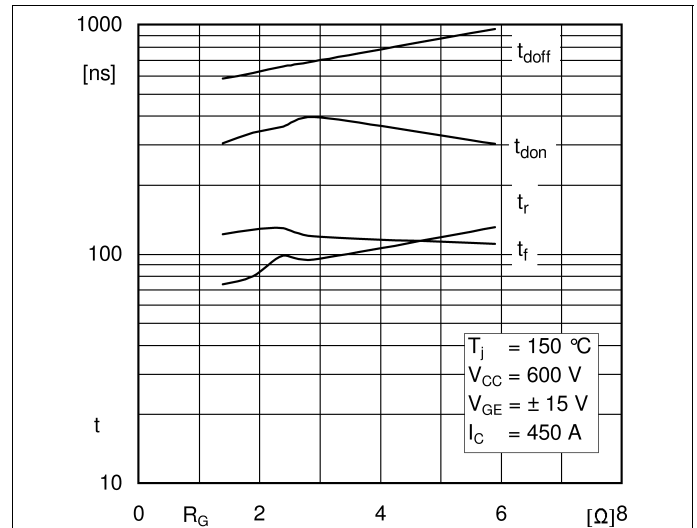
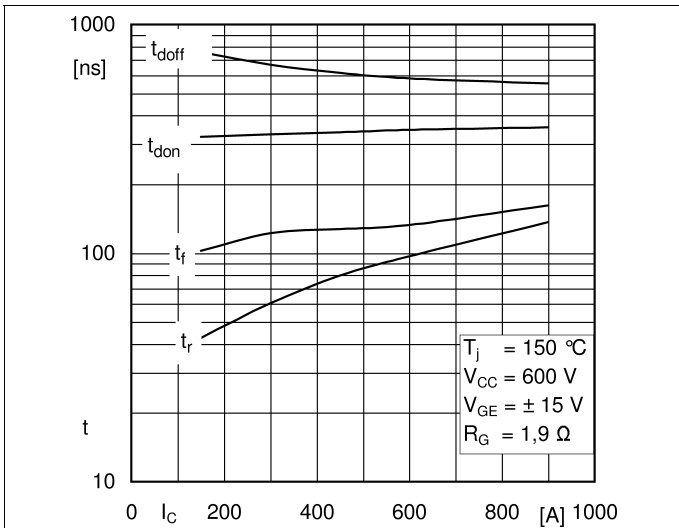
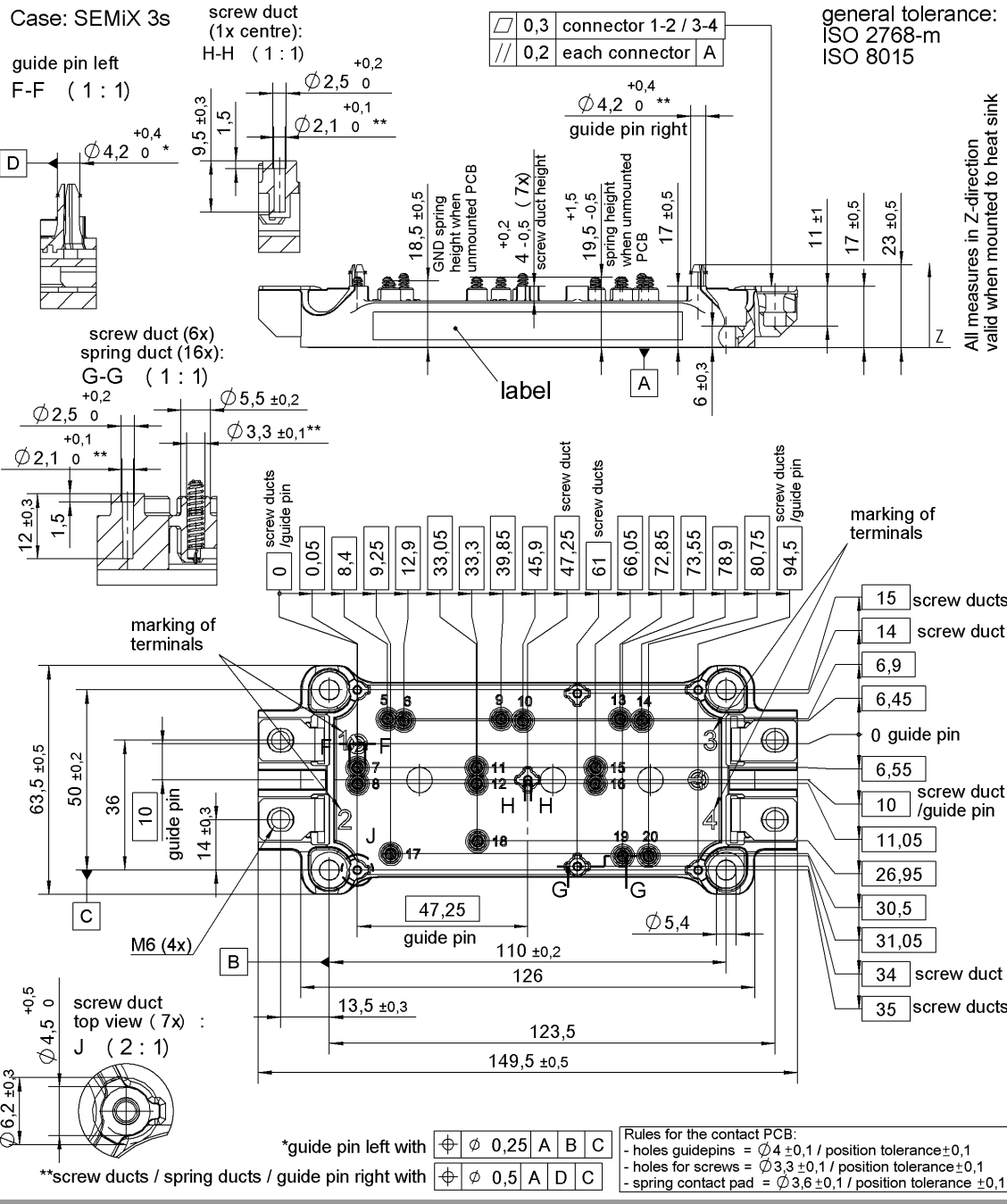


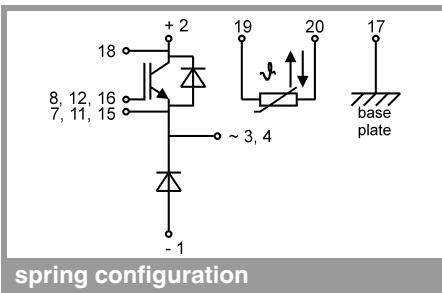
Fig. 6: Typ. gate charge characteristic



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.